

An STJ Spectrometer for High-Resolution Soft X-ray Spectroscopy at the Synchrotron

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Overview

GOAL: High-resolution, user-friendly commercial detector for Synchrotron XAS

X-ray Absorption Spectroscopy

- Synchrotron Radiation, Measurement Techniques
- Partial Fluorescence Yield (PFY)
- Enhanced PFY with High-Resolution Detectors

STJ Detectors

- Operating principle
- Ta device design
- Device characterization
- Array spectra
- Spectrometer System for Synchrotron XAS
 - Requirements
 - Cryogen-free cryostat design



X-ray Absorption Spectroscopy (XAS)



- Information about oxidation state, spin state, chemical coordination, bond characteristics
- Very Soft XAS (100 2000 eV) => Transition metal L-edges and organic K-edges
- Very short attenuation lengths of O(1µm) rule out transmission for many samples
- Both EY and FY rely on assumption that Absorbance proportional to Emission

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Partial Fluorescence Yield XAS



- Background rejection => High sensitivity=> Dilute/trace samples (to PPB)
- Large number of emission spectra needed (one for each XAS point)
- Dilute samples => Large solid angle coverage to acquire signal from species of interest



STJs for XAS



- High resolution, high efficiency fluorescence detector allows greater sensitivity, background rejection

- Need to be FAST to keep up with high flux (>1000 cts/sec/ pixel)



STJ Operating Principle



$$\Delta E_{tot} = \sqrt{\Delta E_{stat}^2 + \Delta E_{tun}^2 + \Delta E_{elec}^2 + \Delta E_{geom}^2}$$

$$\Delta E_{stat} = 2.355 \sqrt{F \epsilon E} \quad \epsilon = 1.7 \Delta$$

$$\Delta E_{tun} = \sqrt{\epsilon E(\langle n \rangle + 1)/\langle n \rangle}$$

- Very Linear response vs. Energy
- No temperature control needed (below cutoff T ~300mK)

High-resolution operation requires:

- Low-noise charge-sensitive preamplifier

6

- Stable biasing at operating point
- Ability to apply magnetic field to suppress DC Josephson current

Segall, K. et al. (2000). Noise mechanisms in superconducting tunnel-junction detectors. Applied Physics Letters, 76(26), 3998-4000.

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STJ Device Design

Photolithographic Process: generate large arrays on single chip



Parameters:

36- and 112-pixel arrays Pixel size: 208µm X 208µm Base electrode thickness: 265nm Top electrode thickness: 300 - 1000nm Shared ground between 8 or 9 pixels



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Device Characterization

Desired Characteristics:

- 1) Low leakage current
- 2) Separation of Fiske modes to provide stable bias points
- 3) Uniformity across array with shared grounds







Spectroscopy with Arrays

Larger arrays => Greater solid angle coverage => More dilute samples







Cryostat Design for XAS

Requirements for Device Operation:

- 1) Sustained operation <300mK
- 2) Magnetic shielding during transition through T_C to prevent flux trapping
- 3) Ability to apply magnetic field to suppress DC Josephson current

Requirements for soft XAS:

- 1) Shares vacuum with sample chamber
- 2) Minimal IR-blocking windows
- 3) Ability to insert into chamber close to sample to maximize solid angle





Cryostat Design for XAS

Automated cool-down and operation, cryogen-free cryostat based on STAR Cryo DRC-100









Commissioning and Testing





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Summary

- STJ Detectors allow increased sensitivity and high speed for soft XAS
- Ta STJs have higher efficiency and resolution than previous Nb-based STJs
- We have fabricated and tested arrays with <10eV resolution below 1 keV
- Design and assembly of cryostat system is complete, testing is underway
- First beam time at LBNL Advanced Light Source in September 2013

Thank you!